

**Search Notes**

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Examiner

Isaac M. Woo

Applicant(s)/Patent under  
Reexamination

YIP ET AL.

Art Unit

2166

**SEARCHED**

Class	Subclass	Date	Examiner

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
See search history printout(s)	5/4/2007	IW